onsemi

MOSFET – N-Channel, POWERTRENCH[®]

100 V, 32 A, 36 m Ω

FDB3682, FDP3682

Features

- $R_{DS(on)} = 32 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 32 \text{ A}$
- $Q_{G(tot)} = 18.5 \text{ nC} (Typ.) @ V_{GS} = 10 \text{ V}$
- Low Miller Charge
- Low Q_{rr} Body Diode
- UIS Capability (Single Pulse and Repetitive Pulse)
- These Devices are Pb-Free and are RoHS Compliant

Applications

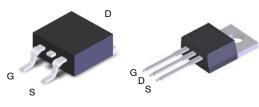
- Consumer Appliances
- Synchronous Rectification
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies
- Micro Solar Inverter

Drain to So		FDB3682 / FDP3682	Unit
Drain to So	Valtaga		
	burce vollage	100	V
Gate to So	urce Voltage	±20	V
Drain Current	Continuous (T _C = 25°C, V _{GS} = 10 V)	32	A
	Continuous (T _C = 100°C, V _{GS} = 10 V)	23	A
	Continuous (T_{amb} = 25°C, V _{GS} = 10 V, $R_{\theta JA}$ = 43°C/W)	6	A
	Pulsed	Figure 4	А
Single Puls	se Avalanche Energy (Note 1)	55	mJ
Power Dissipation		95	W
Derate above 25°C		0.63	mW/°C
Operating	and Storage Temperature	–55 to 175	°C
-	Current Single Puls Power Diss Derate abo	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	$\begin{tabular}{ c c c c c } \hline Current & (T_C = 25^\circ C, V_{GS} = 10 \ V) & Continuous \\ \hline Continuous (T_c = 100^\circ C, V_{GS} = 10 \ V) & Continuous (T_{amb} = 25^\circ C, V_{GS} = 10 \ V, R_{\theta JA} = 43^\circ C/W) & Continuous (T_{amb} = 25^\circ C, V_{GS} = 10 \ V, R_{\theta JA} = 43^\circ C/W) & Figure 4 \\ \hline Continuous Pulsed & Figure 4 & Single Pulse Avalanche Energy (Note 1) & 55 \\ \hline Power Dissipation & 95 \\ \hline Derate above 25^\circ C & 0.63 & Context \\ \hline \end{tabular}$

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

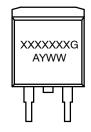
1. Starting $T_J = 25^{\circ}C$, L = 0.27 mH, $I_{AS} = 20 \text{ A}$.



D2PAK-3 (TO-263, 3-LEAD) CASE 418AJ

TO-220-3LD CASE 340AT

MARKING DIAGRAM



XXXXXX = Specific Device Code (FDB3862 or FDP3862)

= Assembly Location

	-		_	-	-	
=	Y	′e	a	r		

А

Y

- WW = Work Week
- G = Pb-Free Package





ORDERING INFORMATION

See detailed ordering and shipping information on page 13 of this data sheet.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case TO-220, TO-263, Max.	1.58	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient TO-220, TO-263 (Note 2), Max.	62	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient TO-263, 1 in ² copper pad area, Max.	43	°C/W

2. Pulse Width = 100 s

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
FF CHARAC	TERISTICS	·				
B _{VDSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	100			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA
		V_{DS} = 80 V, V_{GS} = 0 V, T_{C} = 150°C			250	
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}$			±100	nA
N CHARACT	ERISTICS					
V _{GS(TH)}	Gate to Source Threshold Voltage	$V_{GS}=V_{DS},I_{D}=250\;\mu A$	2		4	V
R _{DS(ON)} Dra	Drain to Source On Resistance	I _D = 32 A, V _{GS} = 10 V		0.032	0.036	Ω
		I _D = 16 V, V _{GS} = 6 V		0.040	0.060	
		I_D = 32 A, V_{GS} = 10 V, T_C = 175 °C		0.080	0.090	
YNAMIC CH	ARACTERISTICS					
C _{ISS}	Input Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V, f = 1 MHz$		1250		pF
C _{OSS}	Output Capacitance			190		pF
C _{RSS}	Reverse Transfer Capacitance	1		45		pF
Q _{g(TOT)}	Total Gate Charge at 10 V	$V_{GS} = 0 V \text{ to } 10 V,$ $V_{DD} = 50 V, I_D = 32 A, I_g = 1.0 \text{ mA}$		18.5	28	nC
Q _{g(TH)}	Threshold Gate Charge	$V_{GS} = 0 V \text{ to } 2 V$, $V_{DD} = 50 V$, $I_D = 32 A$, $I_a = 1.0 \text{ mA}$		2.4	3.6	nC

		$V_{\text{DD}} = 30$ V, $T_{\text{D}} = 02$ A, $T_{\text{g}} = 1.0$ mA		
Q _{gs}	Gate to Source Gate Charge	V_{DD} = 50 V, I_D = 32 A, I_g = 1.0 mA	6.5	nC
Q _{gs2}	Gate Charge Threshold to Plateau		4.1	nC
Q _{gd}	Gate to Drain "Miller" Charge		4.6	nC

RESISTIVE SWITCHING CHARACTERISTICS (V_{GS} = 10 V)

t _{ON}	Turn-On Time	V_{DD} = 50 V, I _D = 32 A, V _{GS} = 10 V, R _{GS} = 16 Ω		83	ns
t _{d(ON)}	Turn-On Delay Time	$v_{GS} = 10 v, H_{GS} = 10 22$	9		ns
t _r	Rise Time		46		ns
t _{d(OFF)}	Turn-Off Delay Time		26		ns
t _f	Fall Time		32		ns
t _{OFF}	Turn-Off Time			87	ns

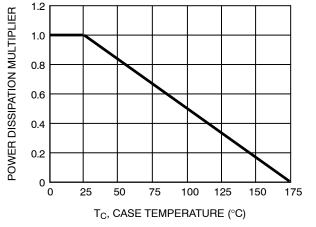
DRAIN-SOURCE DIODE CHARACTERISTICS

V _{SD}	Source to Drain Diode Voltage	I _{SD} = 32 A		1.25	V	
		I _{SD} = 16 A			1.0	V
t _{rr}	Reverse Recovery Time	I_{SD} = 32 A, dI _{SD} /dt = 100 A/µs			55	ns
Q _{RR}	Reverse Recovered Charge	I_{SD} = 32 A, dI _{SD} /dt = 100 A/µs			90	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

(T_C = 25°C unless otherwise noted)





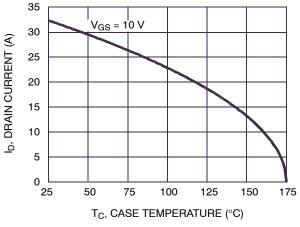


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

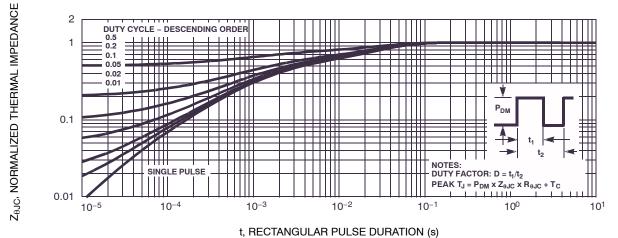


Figure 3. Normalized Maximum Transient Thermal Impedance

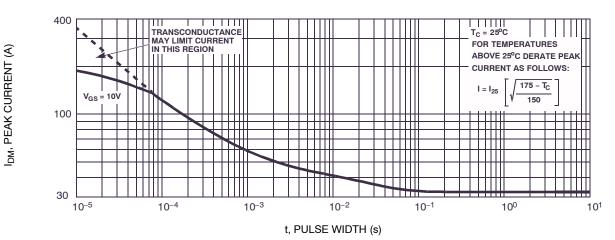


Figure 4. Peak Current Capability

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TYPICAL CHARACTERISTICS

 $(T_C = 25^{\circ}C \text{ unless otherwise noted})$ (continued)

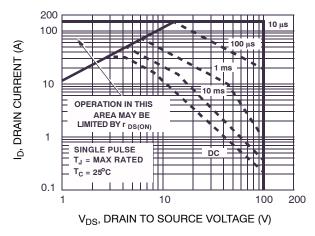


Figure 5. Forward Bias Safe Operating Area

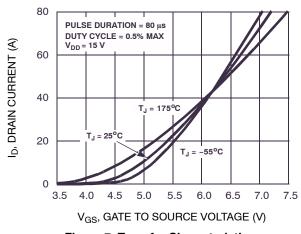
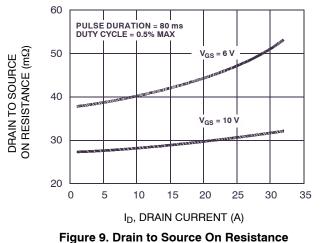
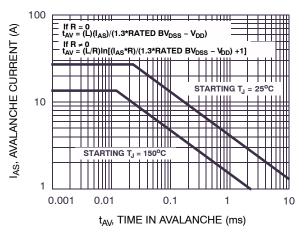


Figure 7. Transfer Characteristics



vs. Drain Current



NOTE: Refer to **onsemi** Application Notes <u>AN-7514</u> and <u>AN-7515</u>

Figure 6. Unclamped Inductive Switching Capability

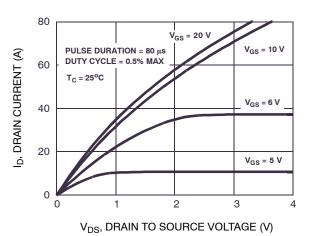
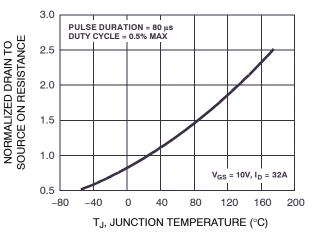
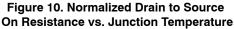


Figure 8. Saturation Characteristics





TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ (continued)

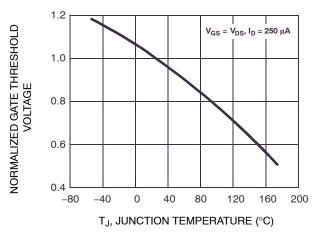


Figure 11. Normalized Gate Threshold Voltage vs. Junction Temperature

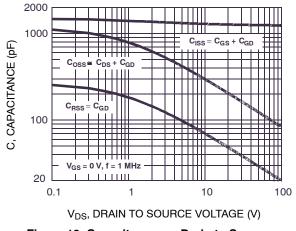


Figure 13. Capacitance vs. Drain to Source Voltage

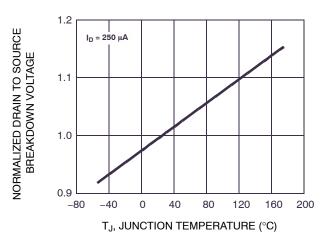


Figure 12. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

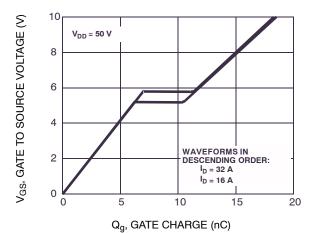


Figure 14. Gate Charge Waveforms for Constant Gate Currents

TEST CIRCUITS AND WAVEFORMS

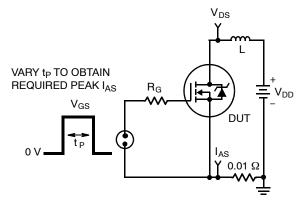


Figure 15. Unclamped Energy Test Circuit

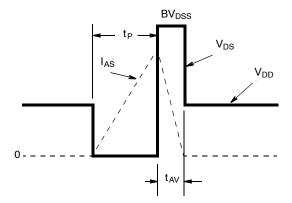


Figure 16. Unclamped Energy Waveforms

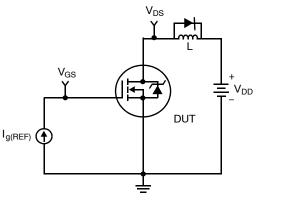


Figure 17. Gate Charge Test Circuit

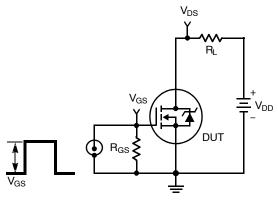


Figure 19. Switching Time Test Circuit

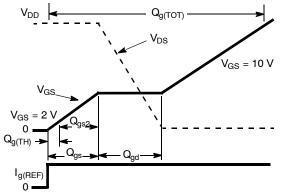


Figure 18. Gate Charge Waveforms

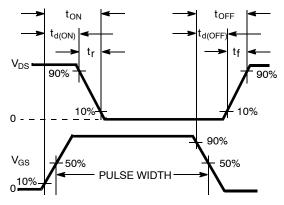


Figure 20. Switching Time Waveforms

THERMAL RESISTANCE VS. MOUNTING PAD AREA

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(eq. 1)

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- 1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

onsemi provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1 oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state

junction temperature or power dissipation. Pulse applications can be evaluated using the **onsemi** device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeter square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$R_{\theta JA} = 26.51 + \frac{19.84}{0.262 + Area}$$
 (eq. 2)
Area in in².

$$R_{\theta JA} = 26.51 + \frac{128}{1.69 + \text{Area}}$$
 (eq. 3)

Area in cm².

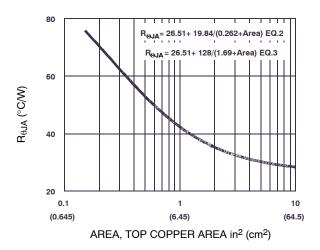


Figure 21. Thermal Resistance vs. Mounting Pad Area

PSPICE ELECTRICAL MODEL

Vbat 22 19 DC 1

S2b 13 15 14 13 S2BMOD

ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*70),2.5))}

.MODEL DbodyMOD D (IS=2.4E-12 RS=4.4e-3 TRS1=2.0e-3 TRS2=4.5e-7 + CJO=9e-10 M=0.57 TT=2.9e-8 XTI=4.0) .MODEL DbreakMOD D (RS=0.6 TRS1=1.4e-3 TRS2=-5.0e-5) .MODEL DplcapMOD D (CJO=2.7e-10 IS=1.0e-30 N=10 M=0.56)

```
.MODEL MstroMOD NMOS (VTO=4.16 KP=32 IS=1e-30 N=10 TOX=1 L=1u W=1u)
.MODEL MmedMOD NMOS (VTO=3.48 KP=2.7 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=1.86)
.MODEL MweakMOD NMOS (VTO=2.97 KP=0.04 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=18.6 RS=0.1)
```

```
.MODEL RbreakMOD RES (TC1=1.05e-3 TC2=-1.1e-8)
.MODEL RdrainMOD RES (TC1=1.6e-2 TC2=4e-5)
.MODEL RSLCMOD RES (TC1=3.0e-3 TC2=2.9e-6)
.MODEL RsourceMOD RES (TC1=1e-3 TC2=1e-6)
.MODEL RvthresMOD RES (TC1=-4.1e-3 TC2=-1.4e-5)
.MODEL RvtempMOD RES (TC1=-3.5e-3 TC2=1.3e-6)
```

.MODEL S1AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-5.0 VOFF=-2.0) .MODEL S1BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-2.0 VOFF=-5.0) .MODEL S2AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-0.4 VOFF=0.3) .MODEL S2BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=0.3 VOFF=-0.4)

.ENDS

NOTE: For further discussion of the PSPICE model, consult A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

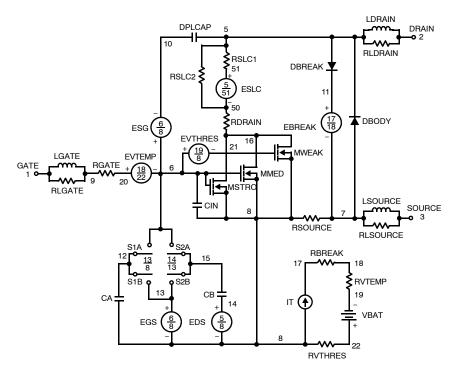


Figure 22.

SABER ELECTRICAL MODEL

```
REV May 2002
template FDB3682 n2,n1,n3
electrical n2,n1,n3
var i iscl
dp..model dbodymod = (isl=2.4e-12, rs=4.4e-3, trs1=2.0e-3, trs2=4.5e-7, cjo=9e-10, m=0.57, tt=2.9e-8, xti=4.0)
dp..model dbreakmod = (rs=0.6, trs1=1.4e-3, trs2=-5e-5)
dp..model dplcapmod = (cjo=2.7e-10, isl=10e-30, nl=10, m=0.56)
m..model mstrongmod = (type= n,vto=4.16,kp=32,is=1e-30,tox=1)
m..model mmedmod = (type= n,vto=3.48,kp=2.7,is=1e-30,tox=1)
m..model mweakmod = (type= n,vto=2.97,kp=0.04,is=1e-30,tox=1,rs=0.1)
sw vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-5,voff=-2)
sw vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-2,voff=-5)
sw vcsp..model s2amod = (ron=1e-5,roff=0.1,von=-0.4,voff=0.3)
sw vcsp..model s2bmod = (ron=1e-5, roff=0.1, von=0.3, voff=-0.4)
c.ca n12 n8 = 4e-10
c.cb n15 n14 = 5.5e-10
c.cin n6 n8 = 1.22e-9
dp.dbody n7 n5 = model=dbodymod
dp.dbreak n5 n11 = model=dbreakmod
dp.dplcap n10 n5 = model=dplcapmod
spe.ebreak n11 n7 n17 n18 = 108
spe.eds n14 n8 n5 n8 = 1
spe.egs n13 n8 n6 n8 = 1
spe.esg n6 n10 n6 n8 = 1
spe.evthres n6 n21 n19 n8 = 1
spe.evtemp n20 n6 n18 n22 = 1
i.it n8 n17 = 1
1.1gate n1 n9 = 5.96e-9
1.1 drain n2 n5 = 1.0 e-9
1.1source n3 n7 = 3.19e-9
res.rlgate n1 n9 = 59.6
res.rldrain n2 n5 = 10
res.rlsource n3 n7 = 31.9
m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u
m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u
m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u
res.rbreak n17 n18 = 1, tc1=1.05e-3,tc2=-1.1e-8
res.rdrain n50 n16 = 10.5e-3, tc1=1.6e-2,tc2=4e-5
res.rgate n9 n20 = 1.86
res.rslc1 n5 n51 = 1.0e-6, tc1=3.0e-3,tc2=2.9e-6
res.rslc2 n5 n50 = 1.0e3
res.rsource n8 n7 = 11.9e-3, tc1=1e-3,tc2=1e-6
res.rvthres n22 n8 = 1, tc1=-4.1e-3,tc2=-1.4e-5
res.rvtemp n18 n19 = 1, tc1=-3.5e-3,tc2=1.3e-6
sw vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw vcsp.s2a n6 n15 n14 n13 = model=s2amod
```

sw vcsp.s2b n13 n15 n14 n13 = model=s2bmod

```
v.vbat n22 n19 = dc=1
equations {
 i (n51->n50) +=iscl
 iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/70))** 2.5))
 }
}
```

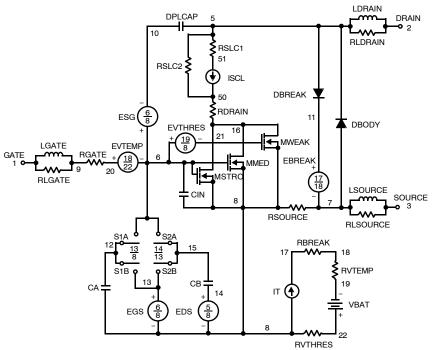


Figure 23.

SPICE THERMAL MODEL

REV 20 May 2002

FDB3682_JC TH TL

CTHERM1 TH 6 1.6e-3 CTHERM2 6 5 4.5e-3 CTHERM3 5 4 5.0e-3 CTHERM4 4 3 8.0e-3 CTHERM5 3 2 8.2e-3 CTHERM6 2 TL 4.7e-2

RTHERM1 TH 6 3.3e-2 RTHERM2 6 5 7.9e-2 RTHERM3 5 4 9.5e-2 RTHERM4 4 3 1.4e-1 RTHERM5 3 2 2.9e-1 RTHERM6 2 TL 6.7e-1

SABER THERMAL MODEL

SABER thermal model FDB3682 template thermal model th tl thermal c th, tl { ctherm.ctherm1 th 6 = 1.6e - 3ctherm.ctherm2 6 5 = 4.5e-3ctherm.ctherm354 = 5.0e - 3ctherm.ctherm4 4 3 =8.0e-3 ctherm.ctherm5 32 = 8.2e - 3ctherm.ctherm6 2 tl =4.7e-2rtherm.rtherm1 th 6 = 3.3e - 2rtherm.rtherm2 6 5 =7.9e-2 rtherm.rtherm354 = 9.5e - 2rtherm.rtherm4 4 3 = 1.4e-1rtherm.rtherm5 3 2 = 2.9e-1rtherm.rtherm6 2 tl =6.7e-1

}

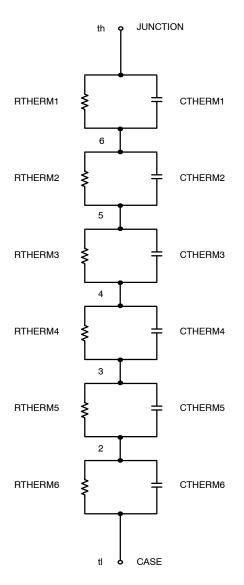


Figure 24.

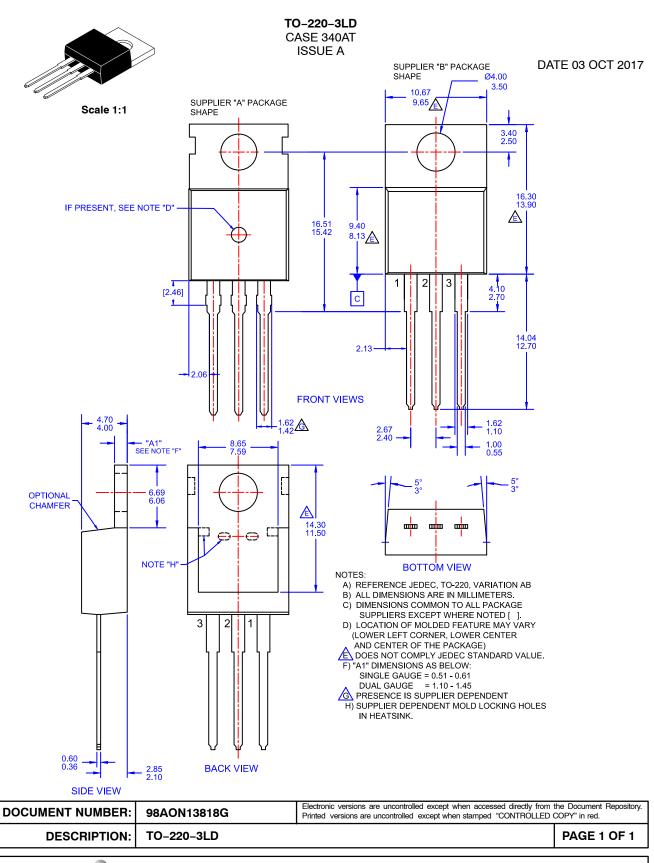
PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package Type	Shipping [†]
FDB3682	FDB3682	D2PAK-3 (TO-263) (Pb-Free)	800 / Tape & Reel
FDP3682	FDP3682	TO-220-3LD (Pb-Free)	800 / Tube

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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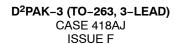




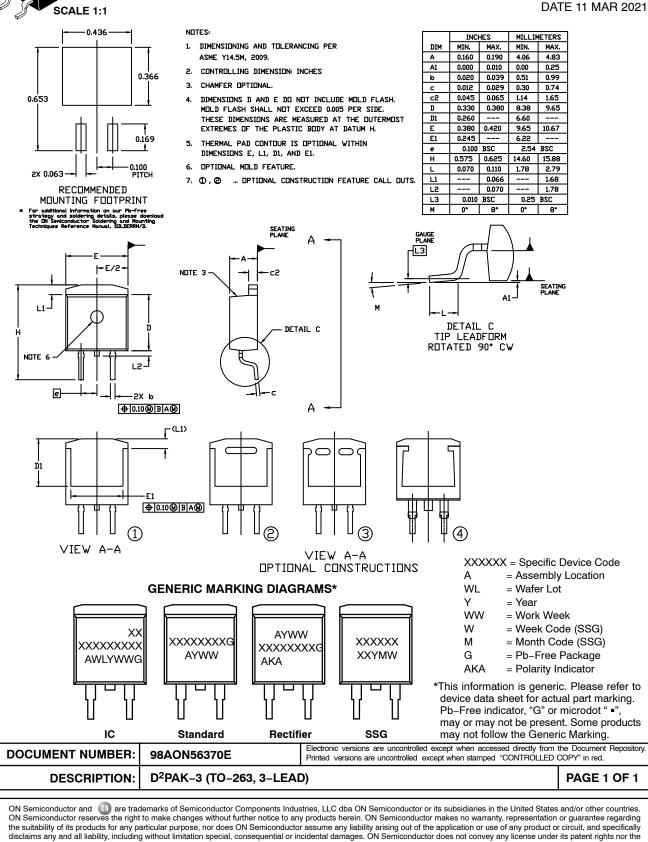
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MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS









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